



Elemental Scientific

prepFAST PPQ

Automate PPQ Metals

prepFAST PPQ



ICP | ICPMS

Automated Sample Preparation and Introduction System for PPQ Metals Determination in High Purity Chemicals

The prepFAST PPQ is the most advanced tool for analyzing ultrapure semiconductor grade chemicals with ICPMS detection. The prepFAST PPQ utilizes syringe-driven flows of UPW, semiconductor grade acids, and standard solution to automate both sample dilutions and standard curve generation. It eliminates manual handling of samples to deliver sub-ppq detection limit capabilities in concentration mode and sub-ppt detection limit capabilities in direct analysis mode.

Two High Purity Modes

Direct Analysis Mode

- Capability to analyze all semiconductor grade chemicals
- Sub-PPT detection limits for all semiconductor elements
- General purpose for any sample matrix
- Automated MSA calibration
- Automated inline dilution

Concentration Mode

- Suitable for UPW, 30% H₂O₂, and IPA
- Sub-PPQ detection limits
- Removes difficult matrices such as IPA while recovering metals
- Removes impact of ICPMS interferences and backgrounds on results
- Amplified sensitivity compared to direct analysis
- Automated MSA calibration

prepFAST PPQ Autocalibration

The prepFAST PPQ automatically prepares calibration curves for over 40 elements controlled in semiconductor manufacturing processes. Calibrations are generated by automatically diluting an enclosed multielement stock standard. Automation with the high-purity prepFAST PPQ achieves low to sub-ppt calibrations in direct analysis mode and low ppq calibrations in concentration mode.



prepFAST PPQ
System

High Purity Automation with PPT/PPQ results

Automation

- Automatic external and MSA calibrations
- Automated sample sensing
 - Accounts for viscosity and automatically adjusts timing
 - Detects and injects the sample and triggers the ICPMS
- Automated syringe-driven sample introduction
 - Sample loading
 - Sample preparation
 - Inline dilution
 - Acid addition (direct mode only)

Ultraclean

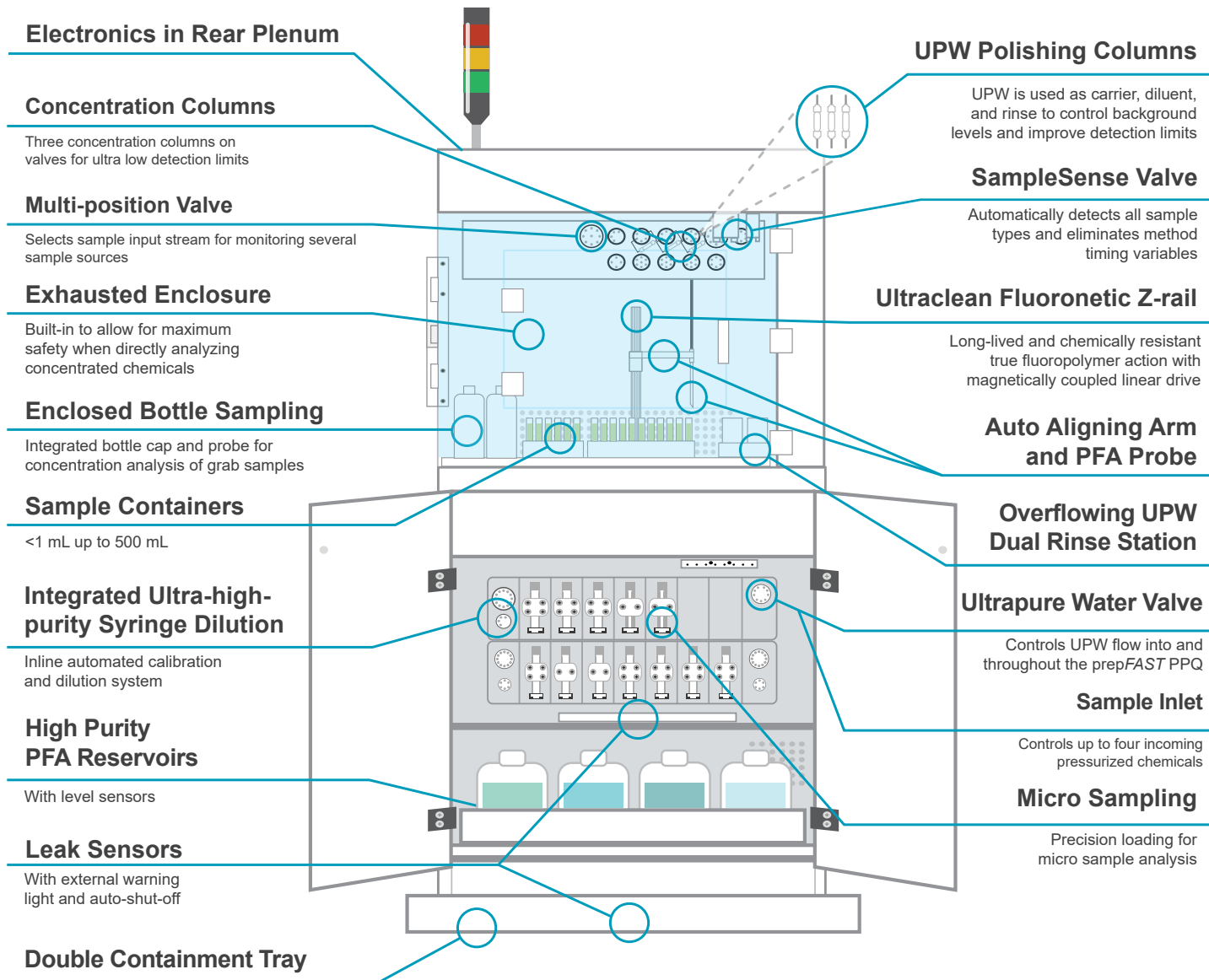
- Ultraclean sample preparation
- Integrated ultraclean sample environment
 - Includes ultraclean air shower
 - Sample racks for PFA containers (<1 mL to 500 mL)
- Continuously-flowing high purity UPW rinse (user-supplied UPW)
- UPW polishing columns for low background

prepFAST PPQ

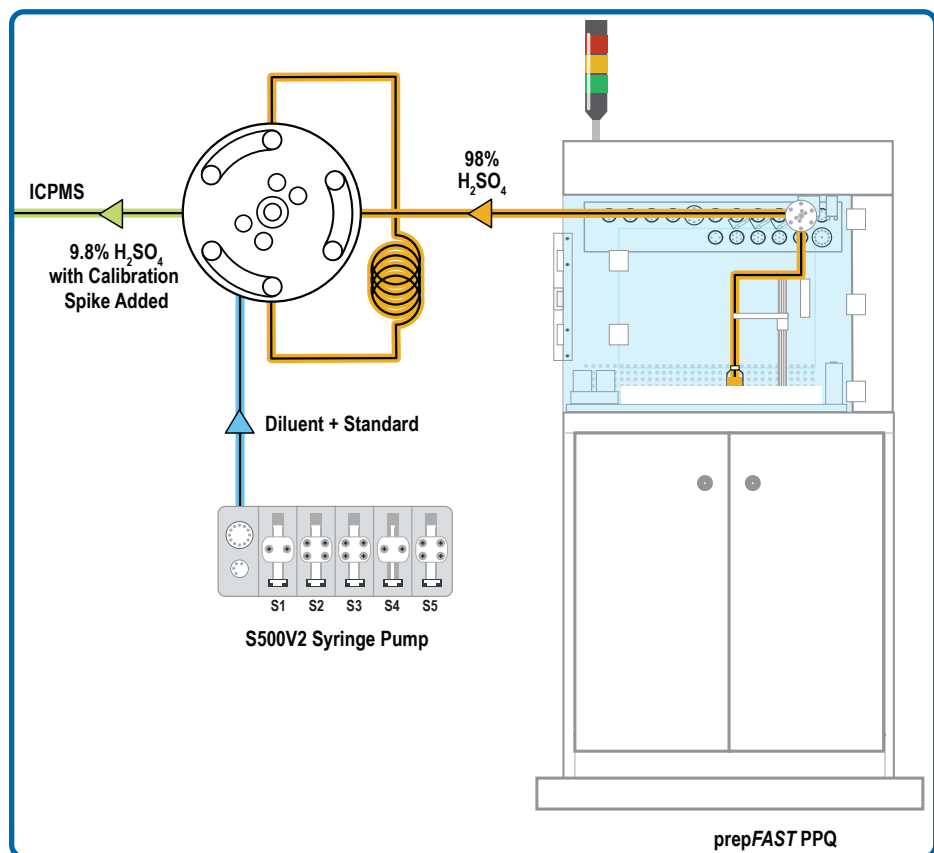
System	Integrated Mobile Autosampler & Enclosure	Ultraclean Air Shower	Integrated FAST valve modules	PFA Nebulizer with Integrated Capillary	PFA Sample Probes	Syringe Pump S500V2
prepFAST PPQ	✓	✓	✓	✓	✓	✓

Pure Automation

prepFAST PPQ



prepFAST PPQ Inline Dilution of Semiconductor-grade Chemicals



The prepFAST PPQ allows dilution by volume or weight for IPA and H₂O₂ in concentration mode, and all semiconductor-grade chemicals in direct analysis mode. Metals are quantified using automated inline MSA or external calibration. Automated direct analysis of concentrated chemicals eliminates sample contamination caused by manual dilution into a secondary container.

Diagram showing 10x inline dilution of concentrated H₂SO₄ with prepFAST PPQ.

Examples of Semiconductor Chemicals Analyzed at the ppt Level with prepFAST PPQ*

Acids	98% H ₂ SO ₄	89% H ₃ PO ₄	70% HNO ₃	49% HF	35% HCl	30% H ₂ O ₂
Bases	22% NH ₄ OH	2.38% TMAH	25% TMAH	KOH		
Organics	IPA	PGMEA/PGME	Photoresist	NMP	Butyl Acetate	Cyclohexanone

*This table contains only a partial list of chemicals which can be analyzed using prepFAST PPQ in direct analysis mode.

Concentration Mode

Sampling Options in Concentration Mode

Direct sample modules

- Availability to monitor up to four pressurized sample lines
- Flushing and sampling processes are controlled by an all-fluoropolymer valve manifold

Enclosed bottle samples

- Rack with integrated probes and caps to keep bottled samples fully enclosed before and during sampling
- Can accommodate up to 2 L bottles
- Automated UPW probe rinse between samples



Layout of four 1 L enclosed bottle samples to the left of the autosampler.

**Example of Detection Limits in Non-Cleanroom Environment
in Concentration Mode (1000x Concentration Factor)**

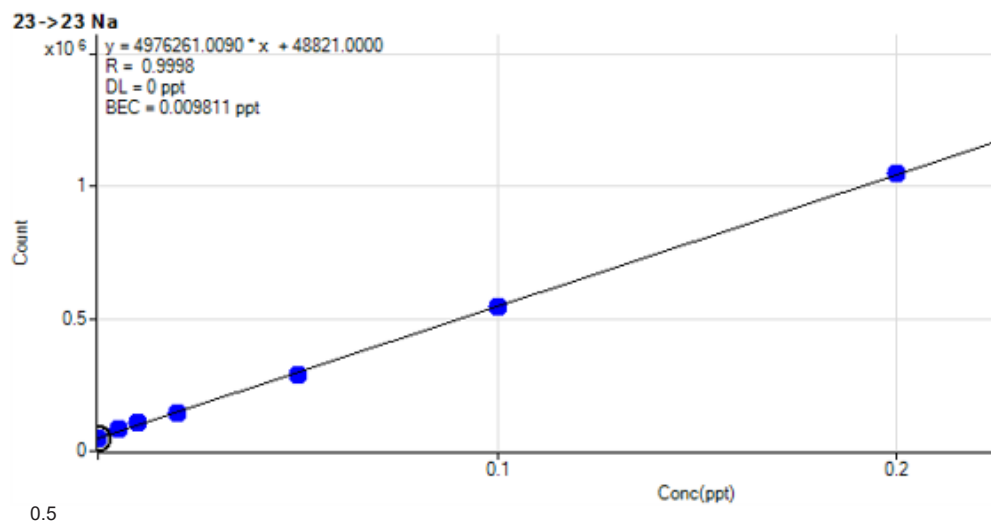
Element	DL (PPQ)	Element	DL (PPQ)
⁷ Li	0.02	⁸⁵ Rb	0.01
¹¹ B	3	⁸⁸ Sr	0.06
²³ Na	0.6	⁹⁰ Zr	0.1
²⁴ Mg	0.2	⁹³ Nb	0.2
²⁷ Al	0.6	⁹⁸ Mo	0.3
²⁸ Si	240	⁷⁵ As	0.2
³⁹ K	0.4	¹⁰⁷ Ag	0.05
⁴⁰ Ca	0.3	¹¹⁴ Cd	0.06
⁴² P	2	¹¹⁵ In	0.01
⁴⁸ Ti	0.2	¹¹⁸ Sn	0.5
⁵¹ V	0.7	¹²¹ Sb	0.4
⁵² Cr	0.4	¹³³ Cs	0.007
⁵⁵ Mn	0.07	¹³⁸ Ba	0.04
⁵⁶ Fe	0.3	¹⁸⁰ Hf	0.2
⁵⁸ Ni	0.07	¹⁸¹ Ta	0.3
⁵⁹ Co	0.01	¹⁸⁴ W	0.4
⁶³ Cu	0.07	¹⁹⁵ Pt	0.1
⁶⁴ Zn	0.4	²⁰⁵ Tl	0.03
⁶⁹ Ga	0.004	²⁰⁸ Pb	0.05
⁷⁴ Ge	0.6	¹⁰⁶ Pd	0.4

Concentration Mode

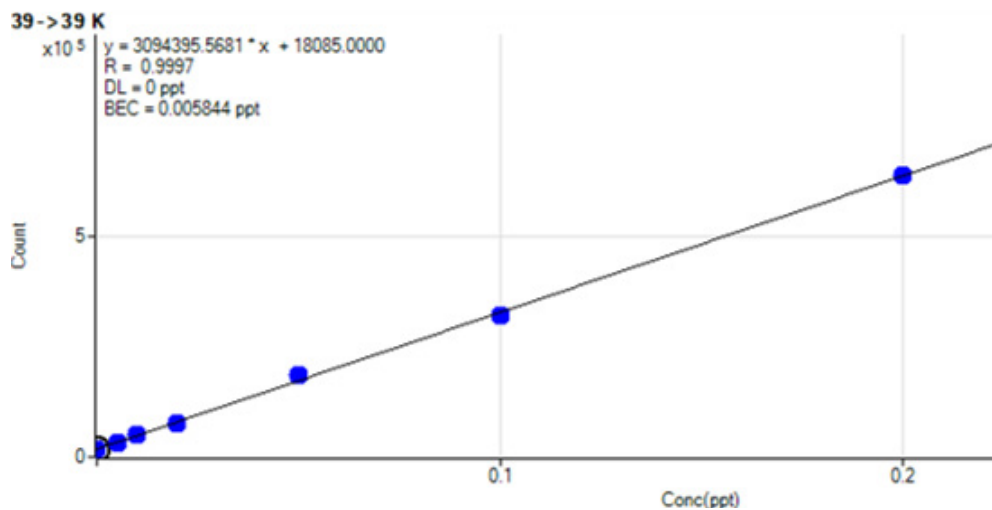
prepFAST PPQ Autocalibration

Autocalibrations for elements controlled in semiconductor manufacturing processes are generated by automatically diluting an enclosed multielement stock standard. Automation with the high-purity prepFAST PPQ achieves ppt to sub-ppt calibration in direct analysis mode and ppq calibrations in concentration mode.

UPW Autocalibration for ^{23}Na

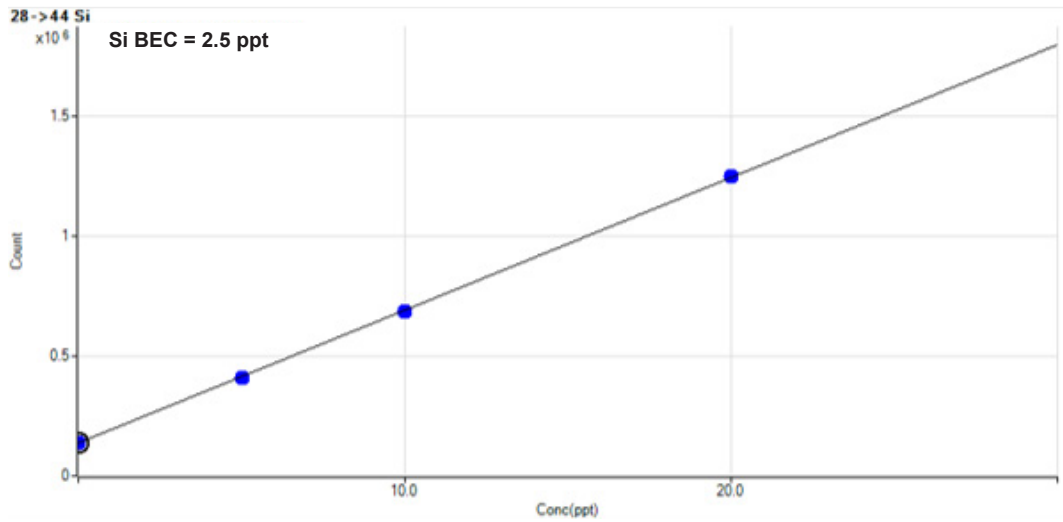


UPW Autocalibration for ^{39}K

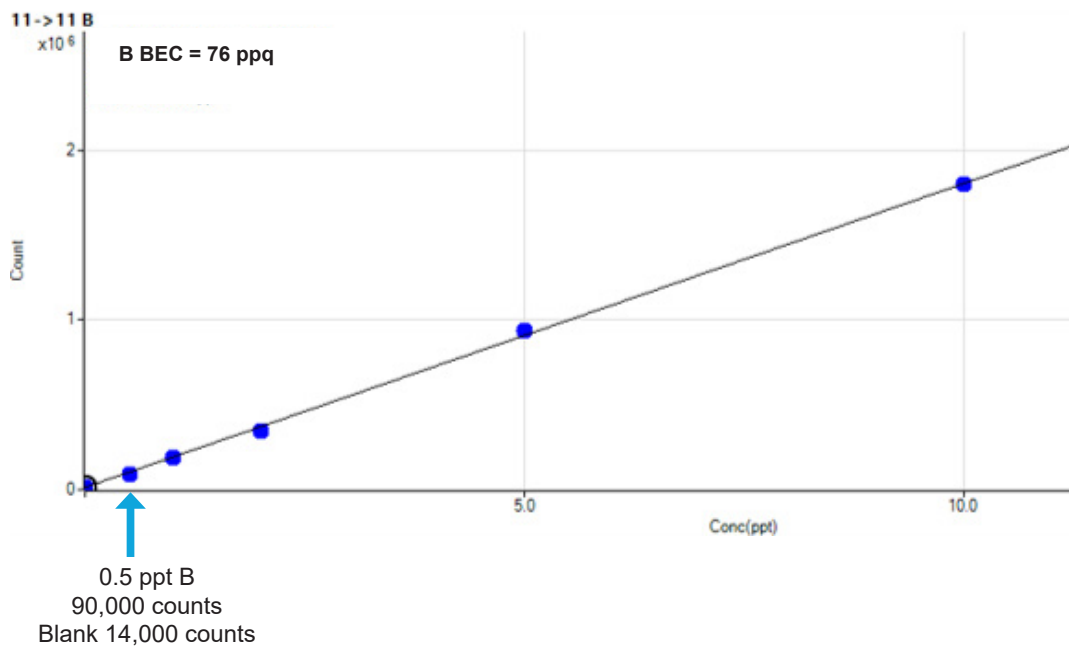


UPW Autocalibration in Concentration Mode

UPW Autocalibration for ^{28}Si



UPW Autocalibration for ^{11}B



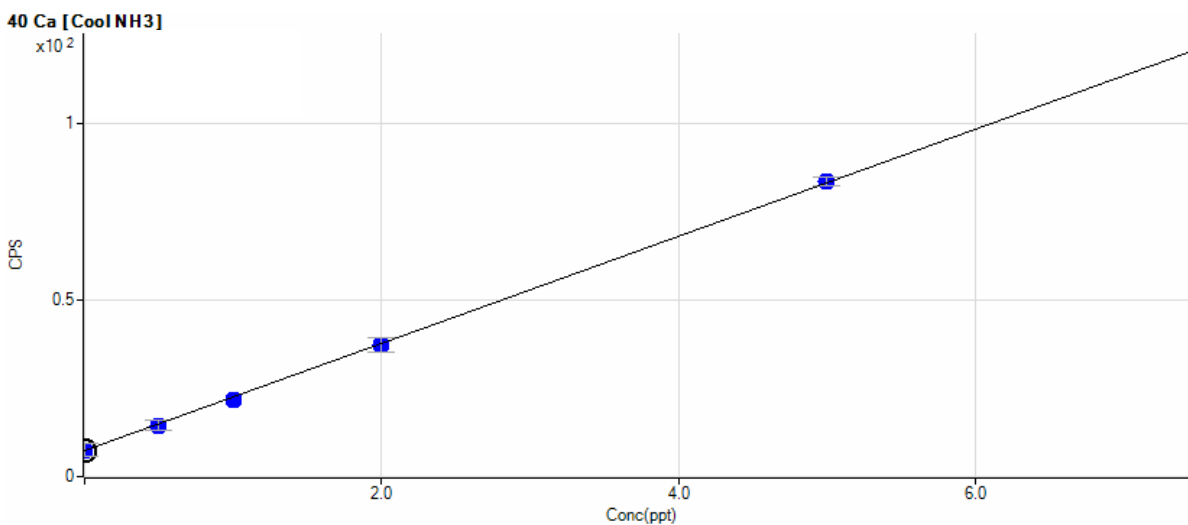
Direct Analysis Mode

Example of Detection Limits in Non-Cleanroom Environment in Direct Analysis Mode

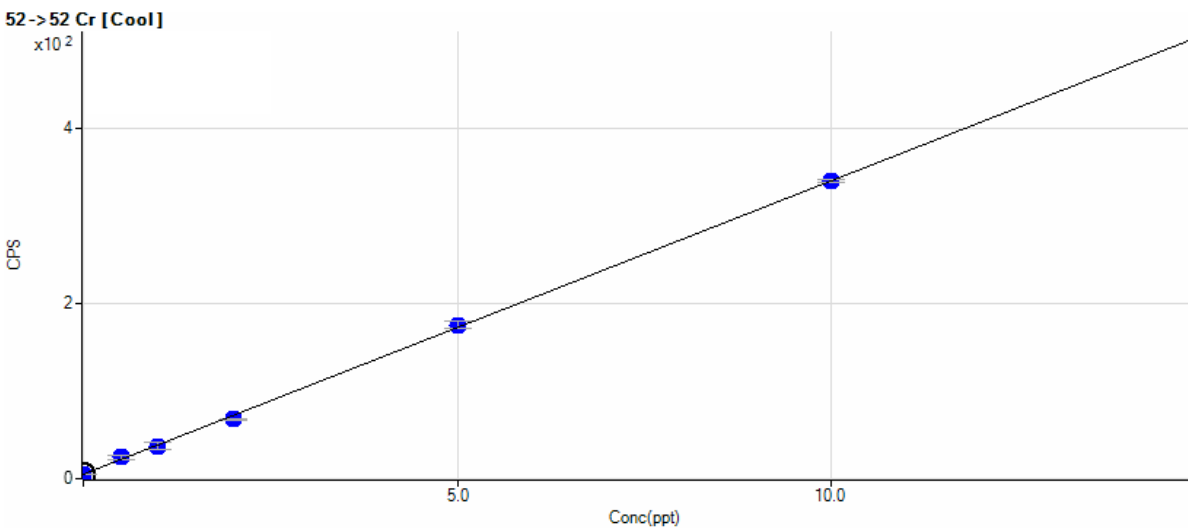
Element	DL (PPT)	Element	DL (PPT)
⁷ Li	0.02	⁷² Ge	0.04
⁹ Be	0.007	⁷⁵ As	0.2
¹¹ B	0.9	⁸⁵ Rb	0.008
²³ Na	0.07	⁸⁸ Sr	0.008
²⁴ Mg	0.01	⁹⁰ Zr	0.004
²⁷ Al	0.03	⁹³ Nb	0.002
³⁹ K	0.06	⁹⁵ Mo	0.5
⁴⁰ Ca	0.4	¹¹¹ Cd	0.07
⁴⁸ Ti	0.02	¹¹⁵ In	0.004
⁵¹ V	0.1	¹¹⁸ Sn	0.05
⁵² Cr	0.1	¹²¹ Sb	0.05
⁵⁵ Mn	0.009	¹³⁷ Ba	0.04
⁵⁶ Fe	0.04	¹⁷⁸ Hf	0.003
⁵⁸ Ni	0.01	¹⁸¹ Ta	0.01
⁵⁹ Co	0.007	¹⁸² W	0.01
⁶⁰ Ni	0.01	²⁰⁵ Tl	0.002
⁶³ Cu	0.03	²⁰⁸ Pb	0.005
⁶⁴ Zn	0.04	²³² Th	0.000
⁷¹ Ga	0.002	²³⁸ U	0.003

Autocalibration in Direct Analysis Mode

UPW Autocalibration for ^{40}Ca



NH_4OH Autocalibration for ^{52}Cr





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